SEMiX405TMLI12E4B

SEMiX® 5

3-Level TNPC IGBT-Module

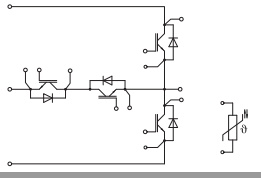
SEMiX405TMLI12E4B

Features*

- Solderless assembling solution with PressFIT signal pins and screw power terminals
- IGBT 4 Trench Gate Technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Reliable mechanical design with injection moulded terminals and reliable internal connections
- UL recognized file no. E63532
- NTC temperature sensor inside

Remarks*

- Case temperature limited to T_C=125°C max
- Product reliability results are valid for T_{jop}=150°C
- IGBT1: outer IGBTs T1 & T4
- IGBT2: inner IGBTs T2 & T3
- Diode1: outer diodes D1 & D4
- Diode2: inner diodes D2 & D3
- For storage and case temperature with TIM see document “TP(HALA P8) SEMiX 5p”



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Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT1				
V_{CES}	T_j = 25 °C		1200	V
I_C	T_j = 175 °C	T_c = 25 °C	636	A
		T_c = 80 °C	490	A
I_{Cnom}			400	A
I_{CRM}			1200	A
V_{GES}			-20 ... 20	V
t_{psc}	V_{CC} = 800 V, V_{GE} ≤ 15 V, T_j = 150 °C, V_{CES} ≤ 1200 V		10	µs
T_j			-40 ... 175	°C
IGBT2				
V_{CES}	T_j = 25 °C		650	V
I_C	T_j = 175 °C	T_c = 25 °C	452	A
		T_c = 80 °C	339	A
I_{Cnom}			400	A
I_{CRM}			1200	A
V_{GES}			-20 ... 20	V
t_{psc}	V_{CC} = 360 V, V_{GE} ≤ 15 V, T_j = 150 °C, V_{CES} ≤ 650 V		10	µs
T_j			-40 ... 175	°C
Diode1				
V_{RRM}	T_j = 25 °C		1200	V
I_F	T_j = 175 °C	T_c = 25 °C	461	A
		T_c = 80 °C	345	A
I_{FRM}			800	A
I_{FSM}	10 ms, sin 180°, T_j = 25 °C		1980	A
T_j			-40 ... 175	°C
Diode2				
V_{RRM}	T_j = 25 °C		650	V
I_F	T_j = 175 °C	T_c = 25 °C	466	A
		T_c = 80 °C	338	A
I_{FRM}			800	A
I_{FSM}	10 ms, sin 180°, T_j = 25 °C		2646	A
T_j			-40 ... 175	°C
Module				
$I_{t(RMS)}$			450	A
T_{stg}	module without TIM		-40 ... 125	°C
V_{isol}	AC sinus 50Hz, t = 1 min		4000	V

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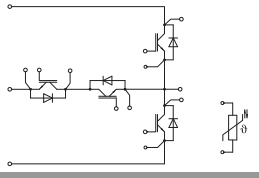

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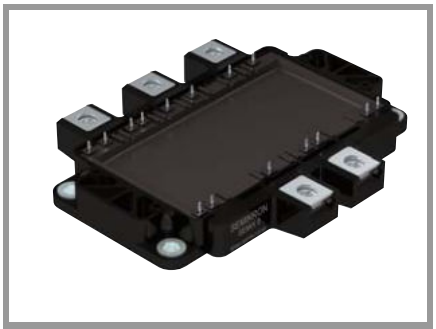
Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
IGBT 1						
$V_{CE(sat)}$	I_C = 400 A V_{GE} = 15 V chiplevel	T_j = 25 °C		1.80	2.05	V
		T_j = 150 °C		2.20	2.40	V
V_{CE0}	chiplevel	T_j = 25 °C		0.80	0.90	V
		T_j = 150 °C		0.70	0.80	V
r_{CE}	V_{GE} = 15 V chiplevel	T_j = 25 °C		2.5	2.9	mΩ
		T_j = 150 °C		3.8	4.0	mΩ
$V_{GE(th)}$	V_{GE} = V_{CE}, I_C = 15.2 mA		5	5.8	6.5	V
I_{CES}	V_{GE} = 0 V, V_{CE} = 1200 V, T_j = 25 °C				5	mA
C_{ies}	V_{CE} = 25 V V_{GE} = 0 V	f = 1 MHz		24.6		nF
C_{oes}		f = 1 MHz		1.62		nF
C_{res}		f = 1 MHz		1.38		nF
Q_G	V_{GE} = -15V...+15V			3026		nC
R_{Gint}	T_j = 25 °C			1.9		Ω
$t_{d(on)}$	V_{CC} = 300 V I_C = 400 A $V_{GE\ neg}$ = -15 V $V_{GE\ pos}$ = 15 V $R_{G\ on}$ = 2.5 Ω $R_{G\ off}$ = 1.5 Ω di/dt_{on} = 3010 A/µs di/dt_{off} = 2740 A/µs dv/dt = 2390 V/µs L_s = 18 nH	T_j = 150 °C		215		ns
t_r		T_j = 150 °C		116		ns
E_{on}		T_j = 150 °C		21.4		mJ
$t_{d(off)}$		T_j = 150 °C		434		ns
t_f		T_j = 150 °C		128		ns
E_{off}		T_j = 150 °C		29		mJ
$t_{d(on)}$	V_{CC} = 300 V I_C = 400 A $V_{GE\ neg}$ = -15 V $V_{GE\ pos}$ = 15 V $R_{G\ on}$ = 1 Ω $R_{G\ off}$ = 1.5 Ω di/dt_{on} = 3800 A/µs di/dt_{off} = 2740 A/µs dv/dt = 2390 V/µs C_{GE} = 22 nF DC-Link-snubber = 680 nF	T_j = 150 °C		222		ns
t_r		T_j = 150 °C		97		ns
E_{on}		T_j = 150 °C		13		mJ
$t_{d(off)}$		T_j = 150 °C		770		ns
t_f		T_j = 150 °C		130		ns
E_{off}		T_j = 150 °C		29		mJ
$R_{th(j-c)}$	per IGBT				0.068	K/W
$R_{th(c-s)}$	per IGBT (λgrease=0.81 W/(m*K))			0.027		K/W
$R_{th(c-s)}$	per IGBT, pre-applied phase change material			0.015		K/W



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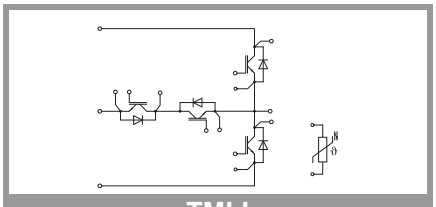
Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
IGBT 2						
$V_{CE(sat)}$	I_C = 400 A V_{GE} = 15 V chiplevel	T_j = 25 °C		1.55	1.95	V
		T_j = 150 °C		1.75	2.15	V
V_{CE0}	chiplevel	T_j = 25 °C		0.90	1.00	V
		T_j = 150 °C		0.82	0.90	V
r_{CE}	V_{GE} = 15 V chiplevel	T_j = 25 °C		1.63	2.4	mΩ
		T_j = 150 °C		2.3	3.1	mΩ
$V_{GE(th)}$	V_{GE} = V_{CE}, I_C = 8 mA		5.1	5.8	6.4	V
I_{CES}	V_{GE} = 0 V, V_{CE} = 650 V, T_j = 25 °C				0.7	mA
C_{ies}	V_{CE} = 25 V V_{GE} = 0 V	f = 1 MHz		24.7		nF
C_{oes}		f = 1 MHz		1.54		nF
C_{res}		f = 1 MHz		0.73		nF
Q_G	V_{GE} = -15V...+15V			4420		nC
R_{Gint}	T_j = 25 °C			1.0		Ω
$t_{d(on)}$	V_{CC} = 300 V I_C = 400 A $R_{G\ on}$ = 0.5 Ω $R_{G\ off}$ = 0.5 Ω di/dt$_{on}$ = 5720 A/µs di/dt$_{off}$ = 2970 A/µs V_{GE} = +15/-15 V dv/dt = 3610 V/µs L_s = 18 nH	T_j = 150 °C		143		ns
t_r		T_j = 150 °C		66		ns
E_{on}		T_j = 150 °C		2.8		mJ
$t_{d(off)}$		T_j = 150 °C		311		ns
t_f		T_j = 150 °C		125		ns
E_{off}		T_j = 150 °C		23.9		mJ
$R_{th(j-c)}$	per IGBT				0.14	K/W
$R_{th(c-s)}$	per IGBT (λgrease=0.81 W/(m*K))			0.058		K/W
$R_{th(c-s)}$	per IGBT, pre-applied phase change material			0.046		K/W

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Diode 1						
V_F = V_{EC}	I_F = 400 A V_{GE} = 0 V chiplevel	T_j = 25 °C		2.20	2.52	V
		T_j = 150 °C		2.15	2.47	V
V_{F0}	chiplevel	T_j = 25 °C		1.30	1.50	V
		T_j = 150 °C		0.90	1.10	V
r_F	chiplevel	T_j = 25 °C		2.3	2.6	mΩ
		T_j = 150 °C		3.1	3.4	mΩ
I_{RRM}	I_F = 400 A di/dt$_{off}$ = 5720 A/µs V_{GE} = -15 V V_{CC} = 300 V	T_j = 150 °C		292		A
Q_{rr}		T_j = 150 °C		52.9		µC
E_{rr}		T_j = 150 °C		16.4		mJ
$R_{th(j-c)}$	per diode				0.13	K/W
$R_{th(c-s)}$	per diode (λgrease=0.81 W/(m*K))			0.036		K/W
$R_{th(c-s)}$	per diode, pre-applied phase change material			0.028		K/W



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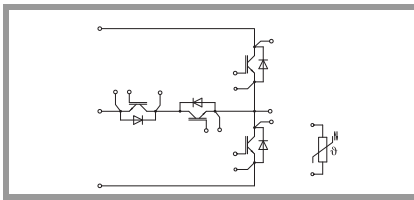

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Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Diode 2						
$V_F = V_{EC}$	I_F = 400 A V_{GE} = 0 V chiplevel	T_j = 25 °C		1.39	1.75	V
		T_j = 150 °C		1.38	1.76	V
V_{F0}	chiplevel	T_j = 25 °C		1.04	1.24	V
		T_j = 150 °C		0.85	0.99	V
r_F	chiplevel	T_j = 25 °C		0.88	1.30	mΩ
		T_j = 150 °C		1.32	1.93	mΩ
I_{RRM}	I_F = 400 A di/dt_{off} = 3010 A/µs V_{GE} = -15 V V_{CC} = 300 V	T_j = 150 °C		227		A
Q_{rr}		T_j = 150 °C		33.5		µC
E_{rr}		T_j = 150 °C		7.8		mJ
I_{RRM}	I_F = 400 A di/dt_{off} = 3800 A/µs V_{GE} = -15 V V_R = 300 V	T_j = 150 °C		314		A
Q_{rr}		T_j = 150 °C		37		µC
E_{rr}		T_j = 150 °C		8.5		mJ
$R_{th(j-c)}$	per diode				0.18	K/W
$R_{th(c-s)}$	per diode (λgrease=0.81 W/(m*K))			0.053		K/W
$R_{th(c-s)}$	per diode, pre-applied phase change material			0.046		K/W

Characteristics

Symbol	Conditions		min.	typ.	max.	Unit
Module						
L_{sCE1}				31		nH
L_{CE}				42		nH
$R_{CC'+EE'}$	measured between terminal 5 and 1	T_C = 25 °C		0.8		mΩ
		T_C = 125 °C		1.1		mΩ
$Rth_{(c-s)1}$	calculated without thermal coupling			0.005		K/W
$Rth_{(c-s)2}$	including thermal coupling, T_s underneath module (λ_{grease}=0.81 W/(m*K))			0.008		K/W
$Rth_{(c-s)2}$	including thermal coupling, T_s underneath module, pre-applied phase change material			0.006		K/W
M_s	to heat sink (M5)		3		6	Nm
M_t	to terminals (M6)		3		6	Nm
w				398		g

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
Temperature Sensor					
R_{100}	T_c=100°C (R_{25}=5 kΩ)		493 ± 5%		Ω
$B_{100/125}$	$R_{(T)}=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; T[K];		3550 ±2%		K

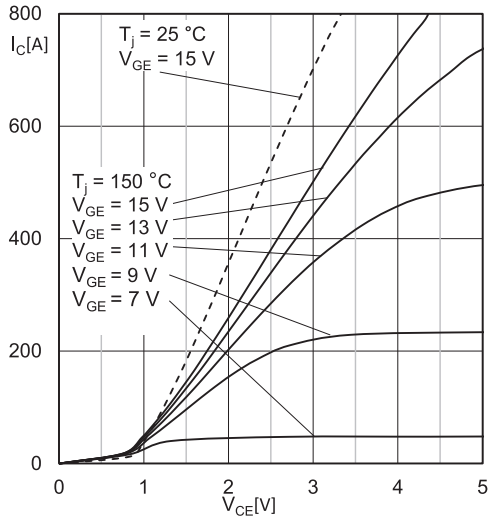


Fig. 1: Typ. IGBT1 output characteristic, incl. $R_{CC'+EE'}$

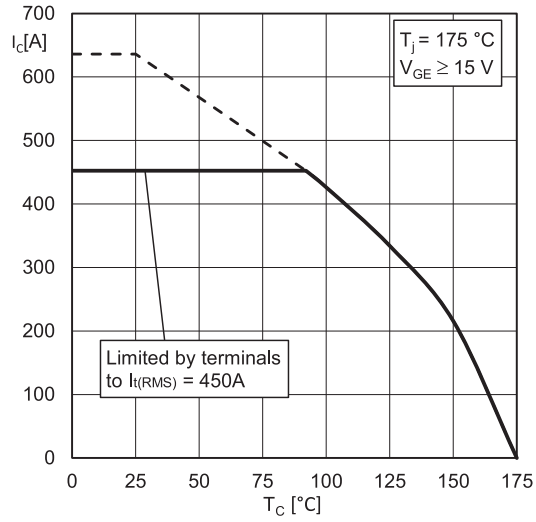


Fig. 2: IGBT1 rated current vs. Temperature $I_c=f(T_c)$

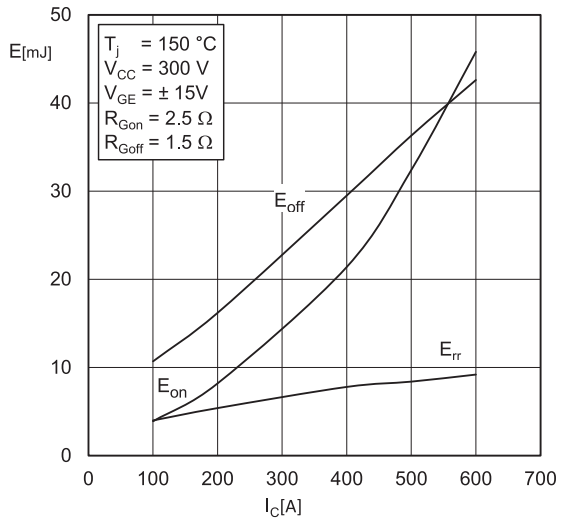


Fig. 3: Typ. IGBT1 & Diode2 turn-on /-off energy = f (I_C)

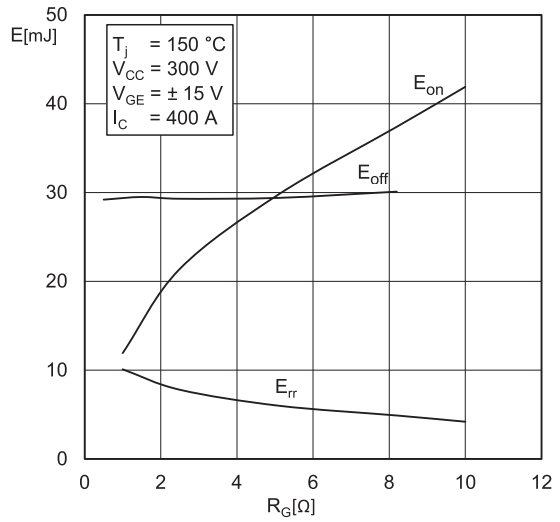


Fig. 4: Typ. IGBT1 & Diode2 turn-on /-off energy = f(R_G)

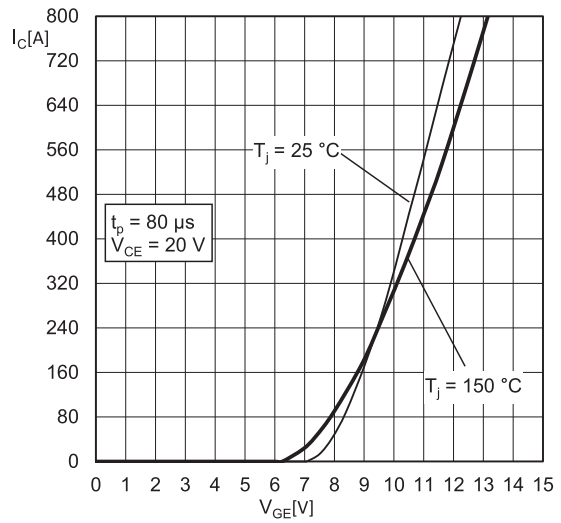


Fig. 5: Typ. IGBT1 transfer characteristic

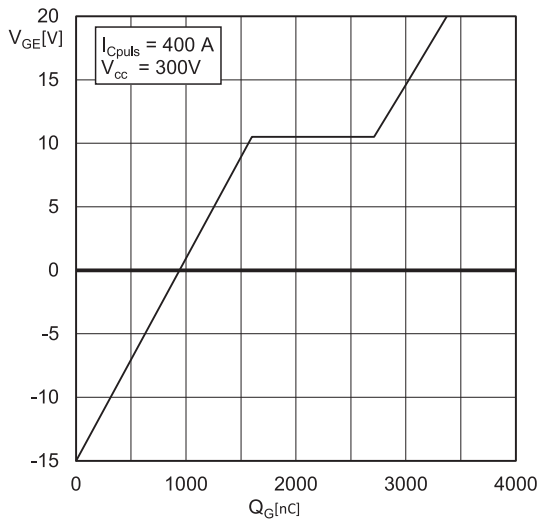


Fig. 6: Typ. IGBT1 gate charge characteristic

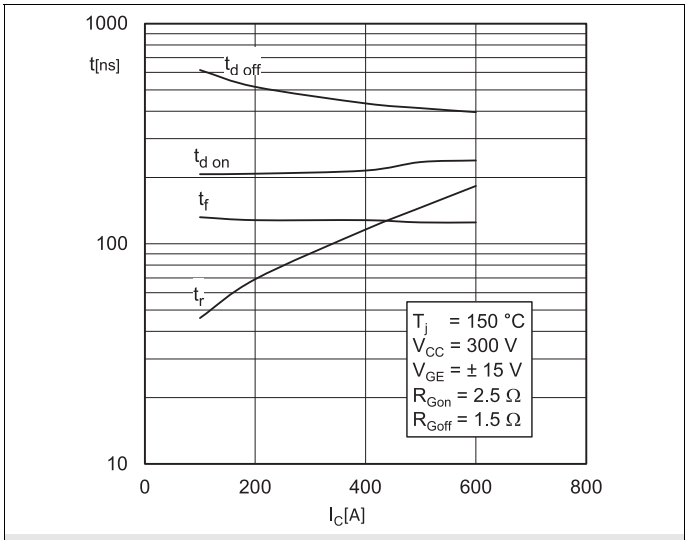


Fig. 7: Typ. IGBT1 switching times vs. I_C

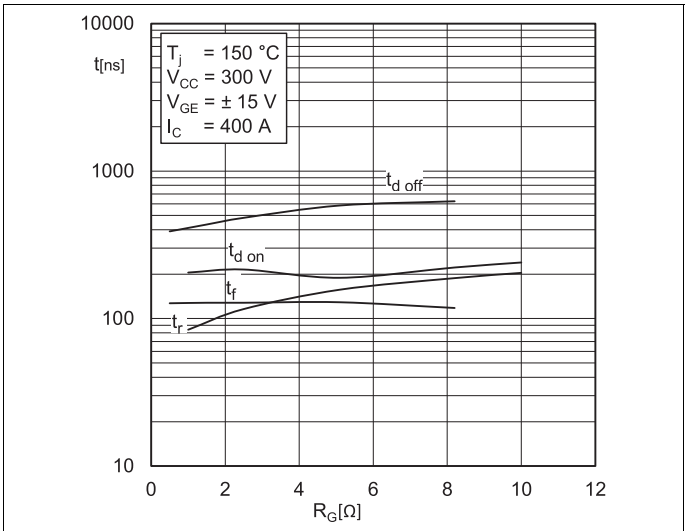


Fig. 8: Typ. IGBT1 switching times vs. gate resistor R_G

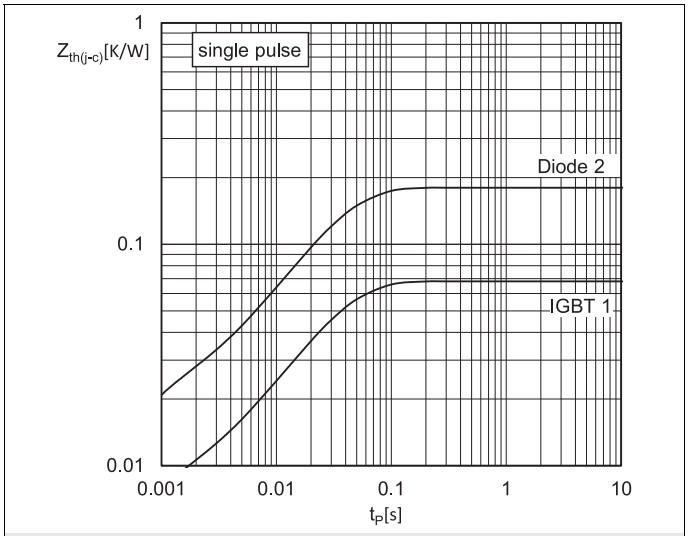


Fig. 9: Typ. Transient thermal impedance of IGBT1 & Diode2

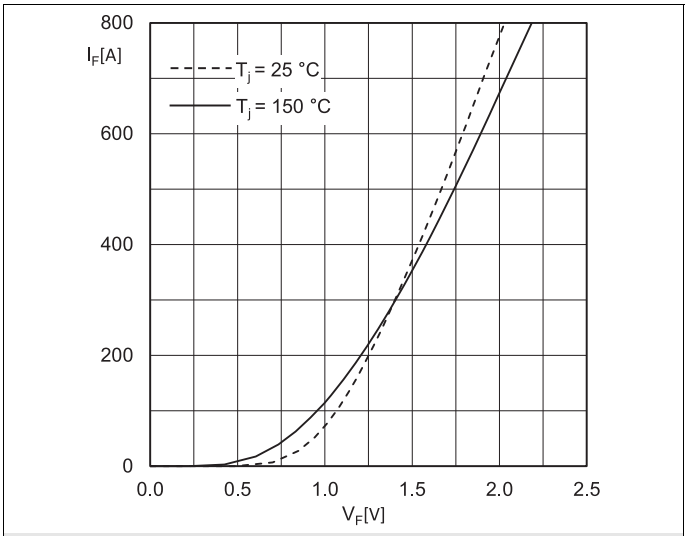


Fig. 10: Typ. Diode2 forward characteristic, incl. $R_{CC'+EE'}$

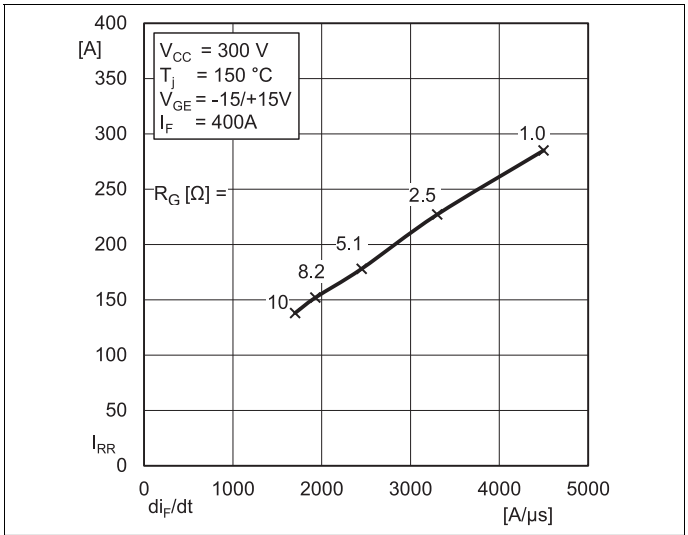


Fig. 11: Typ. Diode2 peak reverse recovery current

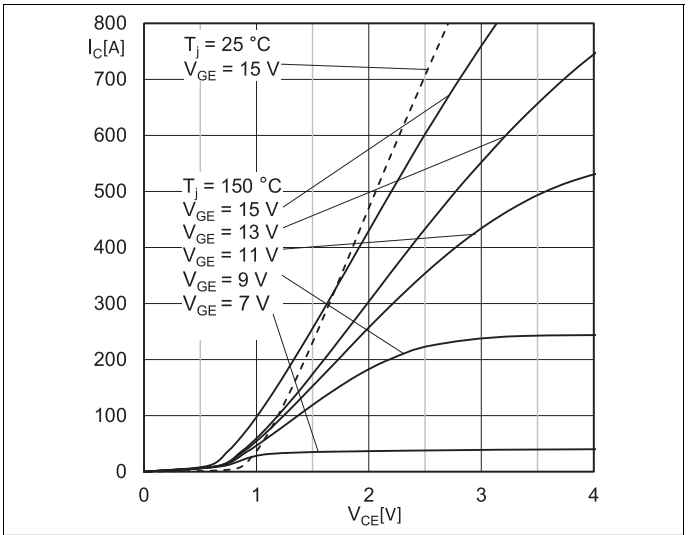


Fig. 13: Typ. IGBT2 output characteristic, incl. $R_{CC'+EE'}$

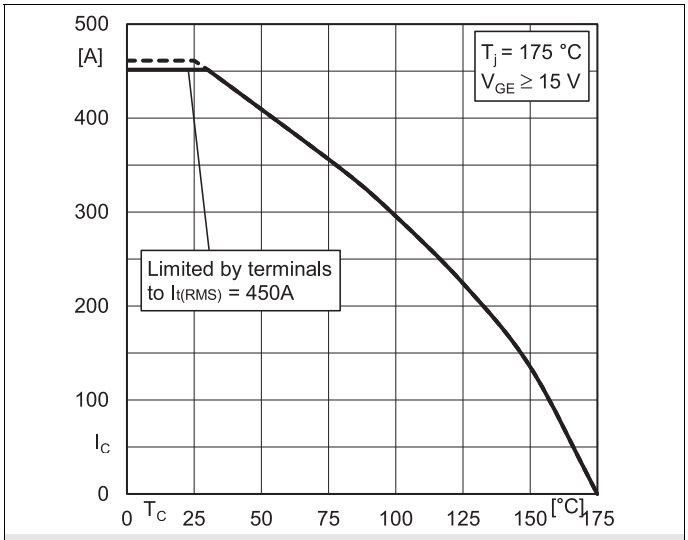


Fig. 14: IGBT2 Rated current vs. Temperature $I_c = f(T_c)$

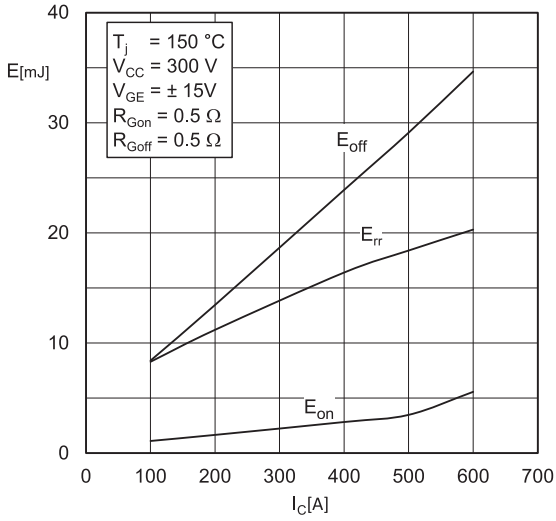


Fig. 15: Typ. IGBT2 & Diode1 turn-on /-off energy = f (I_C)

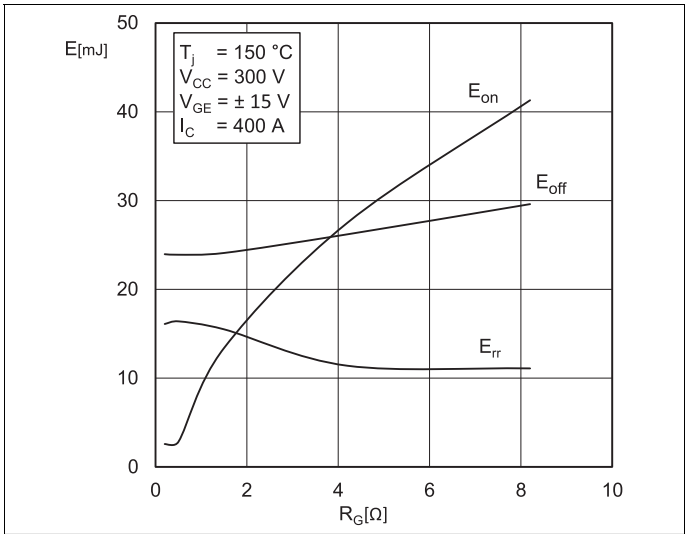


Fig. 16: Typ. IGBT2 & Diode1 turn-on / -off energy = f(R_G)

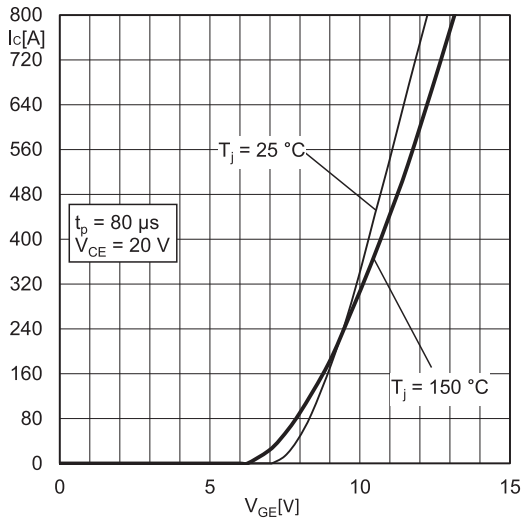


Fig. 17: Typ. IGBT2 transfer characteristic

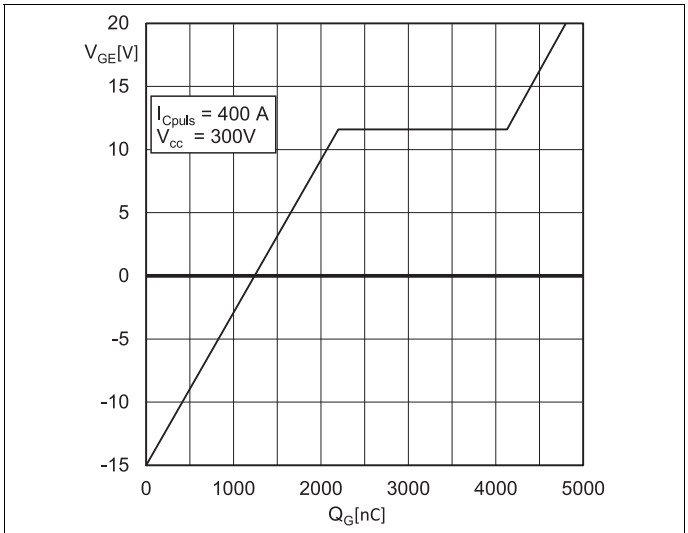


Fig. 18: Typ. IGBT2 gate charge characteristic

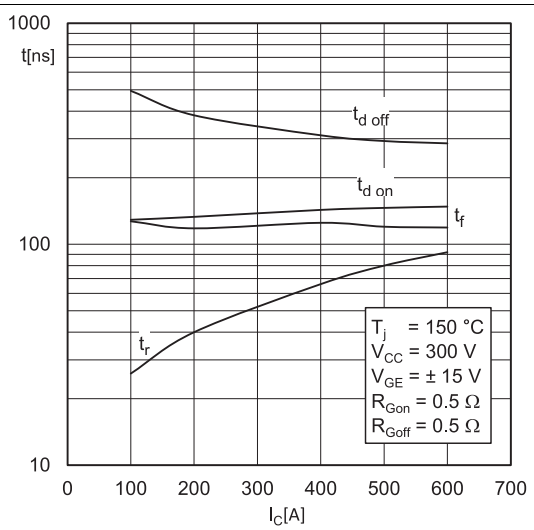


Fig. 19: Typ. IGBT2 switching times vs. I_C

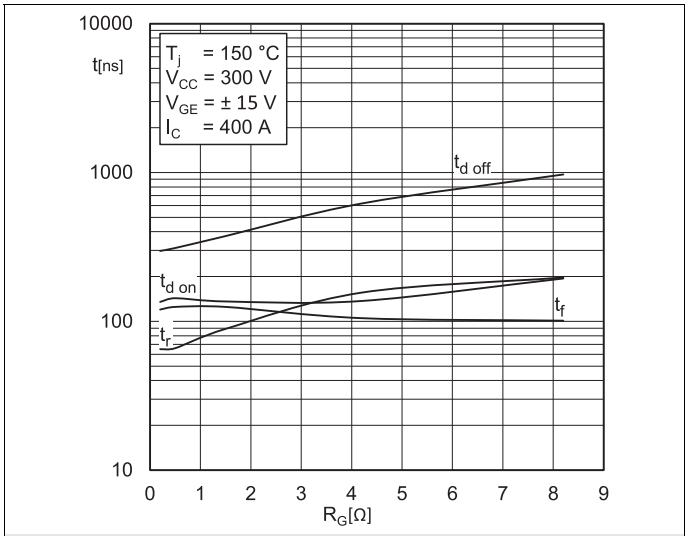


Fig. 20: Typ. IGBT2 switching times vs. gate resistor R_G

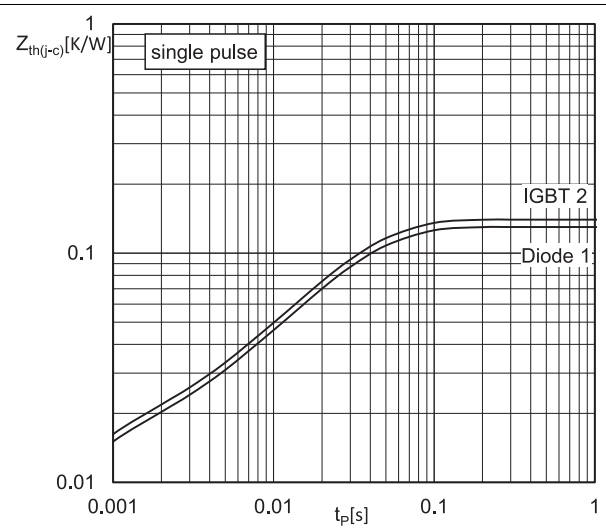


Fig. 21: Transient thermal impedance of IGBT2 & Diode1

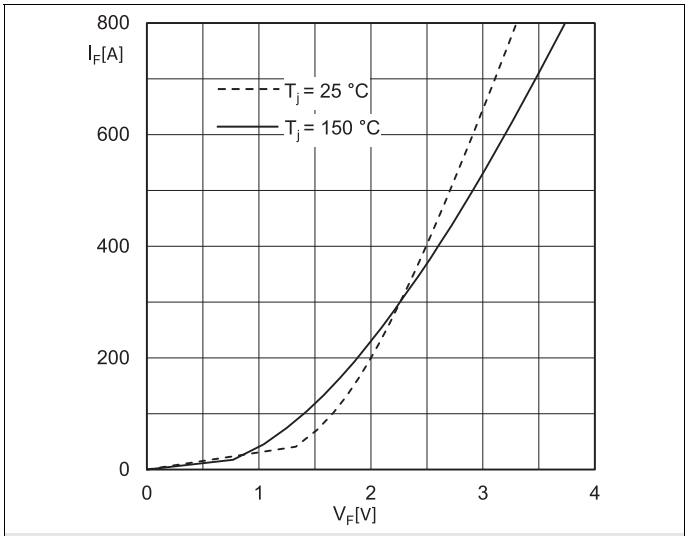


Fig. 22: Typ. Diode1 forward characteristic, incl. $R_{CC'+EE'}$

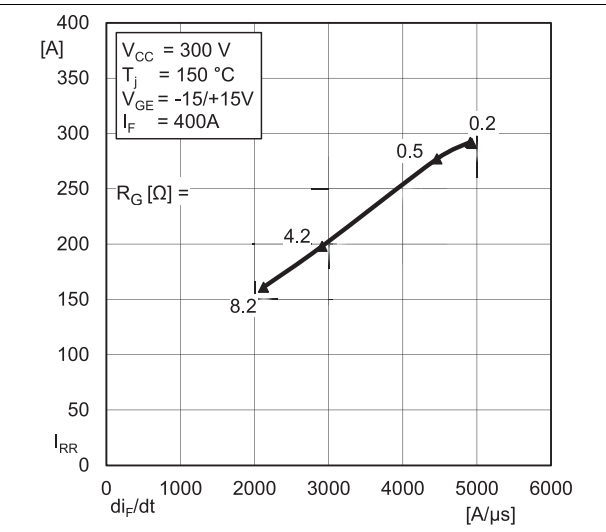
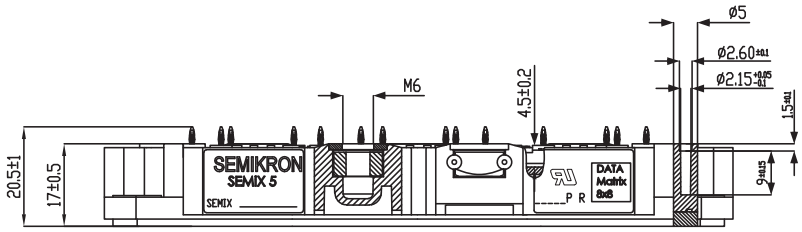
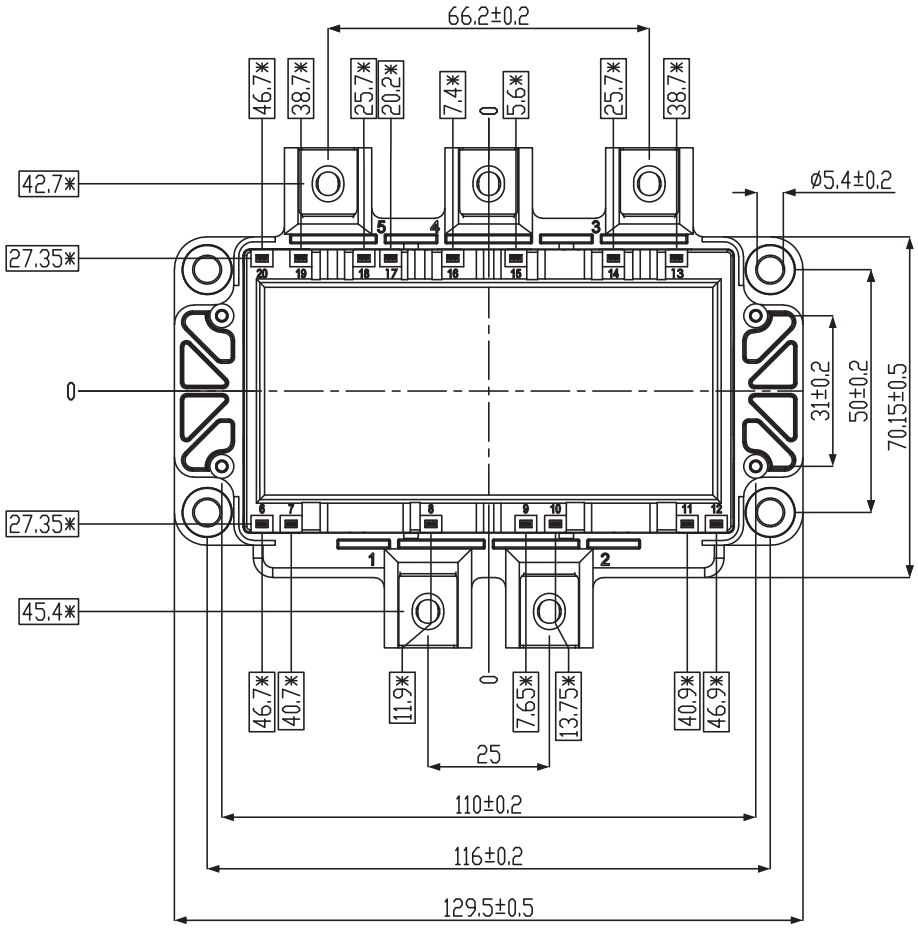


Fig. 23: Typ. Diode1 peak reverse recovery current

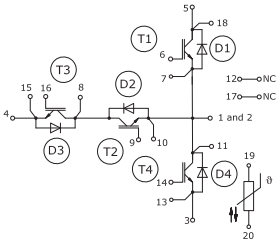




* = Dimensions in mm with tolerance of ⌖ | Ø 0.4

For technical details please refer
to SEMiX(R)5 Mounting Instruction

SEMiX5p



TMLI

This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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